

Notice of References Cited	Application/Control No. 10/517,729		Applicant(s)/Patent Under Reexamination NAKANISHI ET AL.	
	Examiner James W. Rogers, Ph.D.		Art Unit 1618	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,080,396	06-2000	Yokoyama et al.	424/78.08
	B	US-			
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	E	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 397307 A2	11-1990	European Patent	SAKURAI et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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